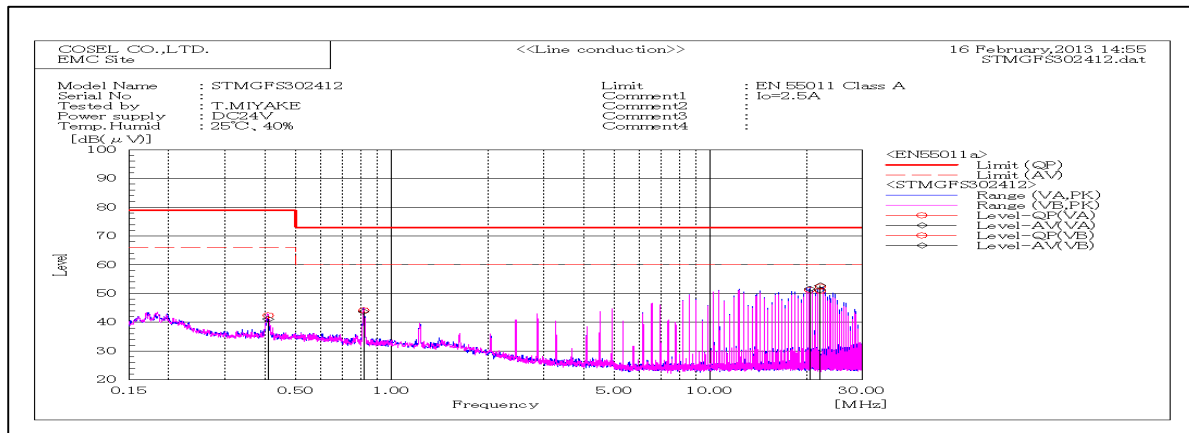
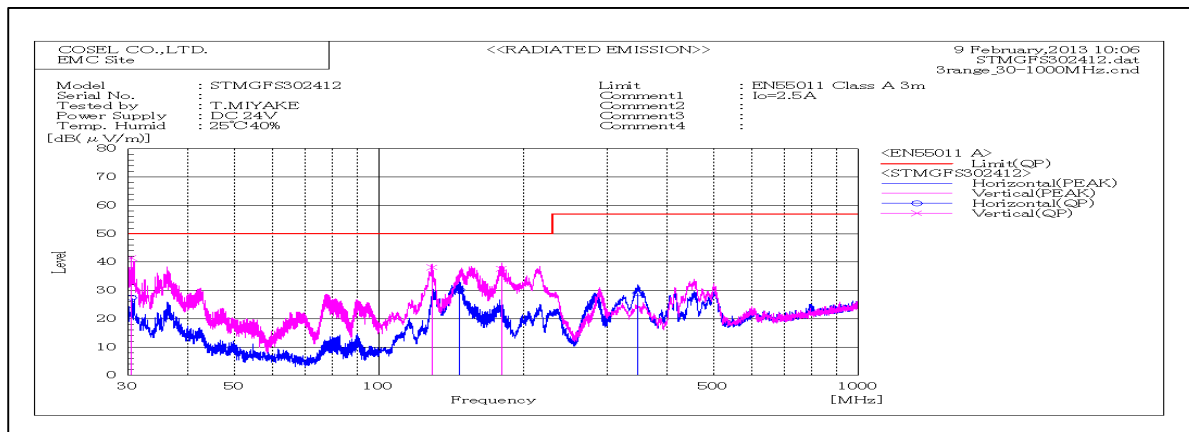


DATA SHEET		Date	18-Feb-13
Model	STMGFS302412	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake



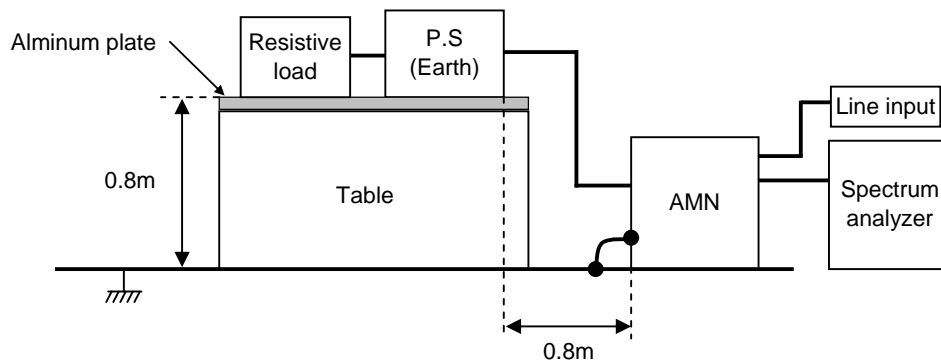
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.41017		VB	22.3	21	20.1	42.4	41.1	79	66	36.6	36.6	Pass	
0.81711		VB	24.1	23.6	20.1	44.2	43.7	73	60	28.8	28.8	Pass	
20.44795		VB	30.1	30.5	21.2	51.3	51.7	73	60	21.7	21.7	Pass	
22.08345		VA	31.3	31.6	21.1	52.4	52.7	73	60	20.6	20.6	Pass	
22.08245		VB	29.8	30.1	21.1	50.9	51.2	73	60	22.1	22.1	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)	Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	QP	QP				
30.429	V	Stable	55.1	-13.6	41.5	50	8.5	Pass	103	139		
30.426	H	Stable	41	-13.6	27.4	50	22.6	Pass	131	130		
129.115	V	Stable	55.6	-17.5	38.1	50	11.9	Pass	104	14		
147.201	H	Stable	50.4	-20.3	30.1	50	19.9	Pass	148	261		
180.107	V	Stable	53.6	-16	37.6	50	12.4	Pass	101	265		
347.471	H	Stable	42.2	-13.2	29	57	28	Pass	119	91		

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

1. Line conduction



2. Radiated emission

